

**Search Notes**

Application/Control No.

10/567,502

Examiner

John P. Sheehan

Applicant(s)/Patent under  
Reexamination

TOMIZAWA ET AL.

Art Unit

1793

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/25/2008	JPS